

N AND P-CHANNEL POWER MOSFET

GENERAL DESCRIPTION

The SFS0407T4 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

FEATURES

◆ N-CHANNEL

$V_{DS}=40V, I_D=7A$

$R_{DS(ON)}=20.0m\Omega$ (TYP@ $V_{GS}=10V$)

$R_{DS(ON)}=24.0m\Omega$ (TYP@ $V_{GS}=4.5V$)

◆ P-CHANNEL

$V_{DS}=-40V, I_D=-7A$

$R_{DS(ON)}=30.0m\Omega$ (TYP@ $V_{GS}=-10V$)

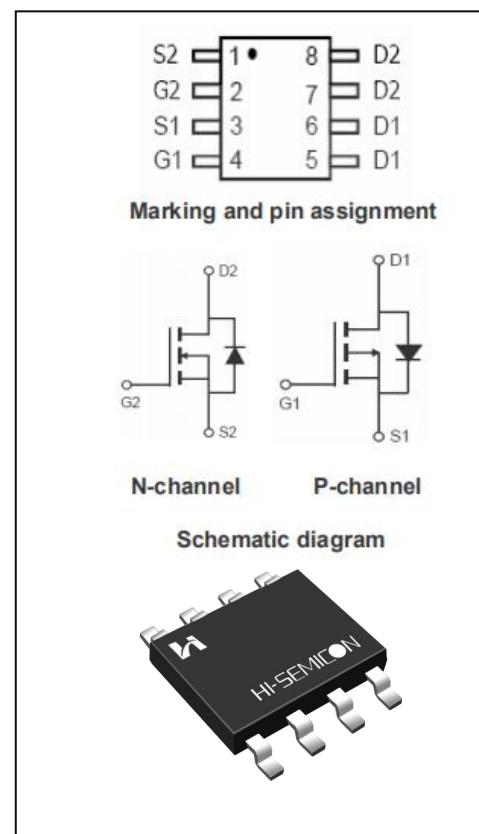
$R_{DS(ON)}=37.0m\Omega$ (TYP@ $V_{GS}=-4.5V$)

◆ High density cell design for ultra low $R_{DS(ON)}$

◆ Special process technology for high ESD capability

◆ Exceptional on-resistance and maximum DC

Current capability



ORDERING INFORMATION

Part No.	Package	Marking	Material	Packing
SFS0407T4	SOP8-8L	SFS0407T4	Pb Free	Reel

ABSOLUTE MAXIMUM RATINGS (T_J=25°C unless otherwise noted)

Characteristics		Symbol	N-CHANNEL	P-CHANNEL	UNIT
Drain-Source Voltage		V _{DS}	40	-40	V
Gate-Source Voltage		V _{GS}	±20	±20	V
Drain Current	TC=25°C	I _D	7	-7	A
	TC=70°C		5.5	-5.5	A
Pulsed Drain Current(note1)		I _{DM}	28	-28	A
Power Dissipation	TC=25°C	P _D	2.0		W
Thermal Characteristics					
Maximum Junction-to-Lead		R _{θJL}	62.5		°C/W
Junction and Storage Temperature Range		T _{J,T_{stg}}	-55 to +150		°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		T _L	300		°C

N-CHANNEL ELECTRICAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain -Source Breakdown Voltage	B _{VDS}	V _{GS} =0V, I _D =250μA	40	--	-	V
Drain-Source Leakage Current	I _{DS}	V _{DS} =40V, V _{GS} =0V	-	--	1	uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =20V, V _{DS} =0V	-	--	100	nA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =-20V, V _{DS} =0V	-	--	-100	nA
On Characteristics						
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D =250μA	1	1.6	2.5	V
Static Drain- Source On State Resistance	R _{DS(on)}	V _{GS} =10V, I _D =4A	-	20.0	23.0	mΩ
		V _{GS} =4.5V, I _D =4A	-	24.0	45.0	mΩ
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{DS} =20V V _{GS} =0V f=1.0MHZ	-	692	-	pF
Output Capacitance	C _{oss}		-	70	-	
Reverse Transfer Capacitance	C _{rss}		-	65	-	
Switching Characteristics						
Turn-on Delay Time	t _{d(on)}	V _{DD} =20V V _{GS} =10V R _G =3.3Ω I _D =4A (Note 2.3)	-	9.6	-	ns
Turn-on Rise Time	t _r		-	8.5	-	
Turn-off Delay Time	t _{d(off)}		-	23.1	-	
Turn-off Fall Time	t _f		-	5.1	-	
Total Gate Charge	Q _g	V _{DS} =20V, I _D =4A V _{GS} =10V (Note 2.3)	-	9.2	-	nC
Gate-Source Charge	Q _{gs}		-	3.5	-	
Gate-Drain Charge	Q _{gd}		-	5.2	-	

N-CHANNEL SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I _S	Integral Reverse P-N Junction Diode in the MOSFET	-	-	7	A
Pulsed Source Current	I _{SM}		-	-	28	
Diode Forward Voltage	V _{SD}	I _S =5A, V _{GS} =0V	-	0.83	1.3	V

P-CHANNEL ELECTRICAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain -Source Breakdown Voltage	B _{VDSS}	V _{GS} =0V, I _D =-250μA	-40	-	-	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =-40V, V _{GS} =0V	-	-	-1	uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =20V, V _{DS} =0V	-	-	100	nA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =-20V, V _{DS} =0V	-	-	-100	nA
On Characteristics						
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D =-250μA	-1.3	-1.6	-2.1	V
Static Drain- Source On State Resistance	R _{DS(on)}	V _{GS} =-10V, I _D =-4A	-	30.0	35.0	mΩ
		V _{GS} =-4.5V, I _D =-4A	-	37.0	50.0	
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{DS} =-20V V _{GS} =0V f=1.0MHZ	-	897	-	pF
Output Capacitance	C _{oss}		-	84	-	
Reverse Transfer Capacitance	C _{rss}		-	73	-	
Switching Characteristics						
Turn-on Delay Time	t _{d(on)}	V _{DD} =-20V V _{GS} =-10V R _G =3Ω I _D =-4A (Note 2.3)	-	7.6	-	ns
Turn-on Rise Time	t _r		-	12.3	-	
Turn-off Delay Time	t _{d(off)}		-	31.2	-	
Turn-off Fall Time	t _f		-	17.5	-	
Total Gate Charge	Q _g	V _{DS} =-20V I _D =-4A V _{GS} =-10V (Note 2.3)	-	16.5	-	nC
Gate-Source Charge	Q _{gs}		-	3.6	-	
Gate-Drain Charge	Q _{gd}		-	4.7	-	

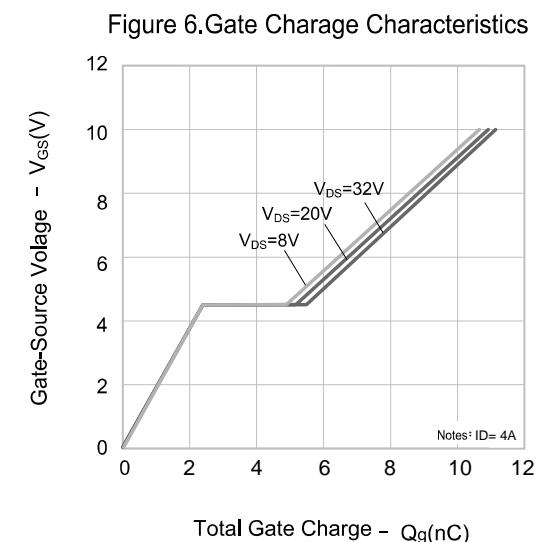
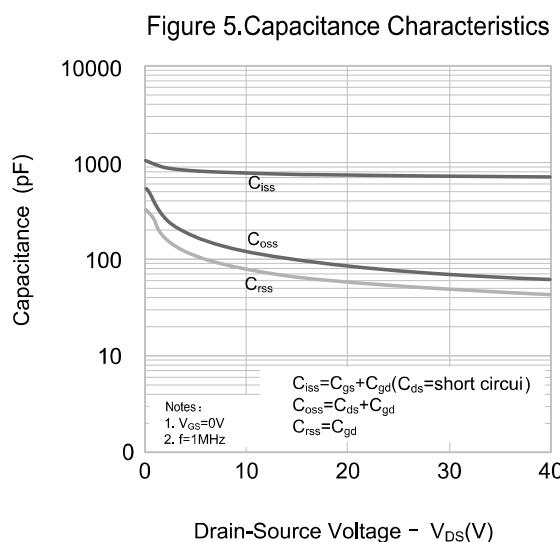
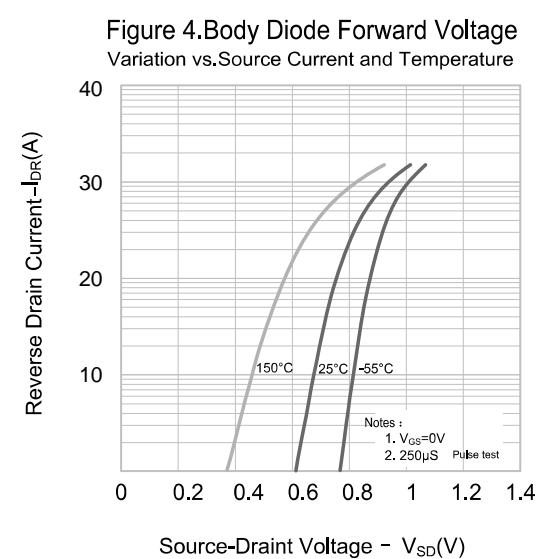
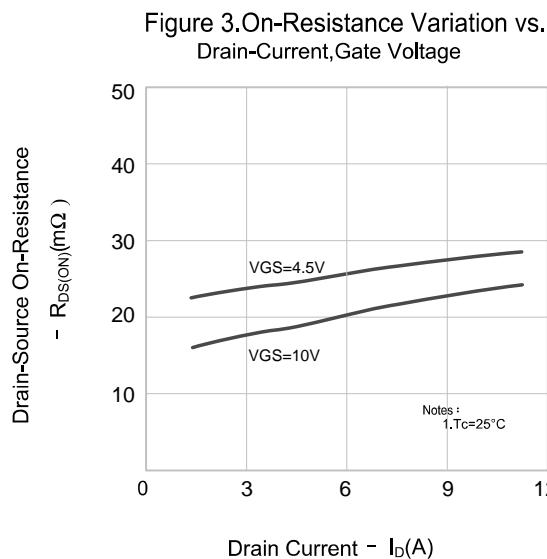
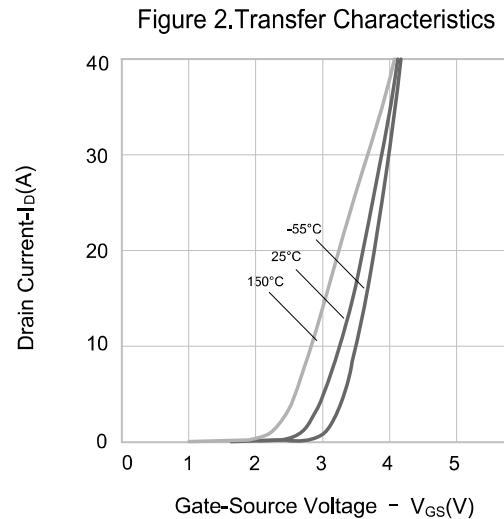
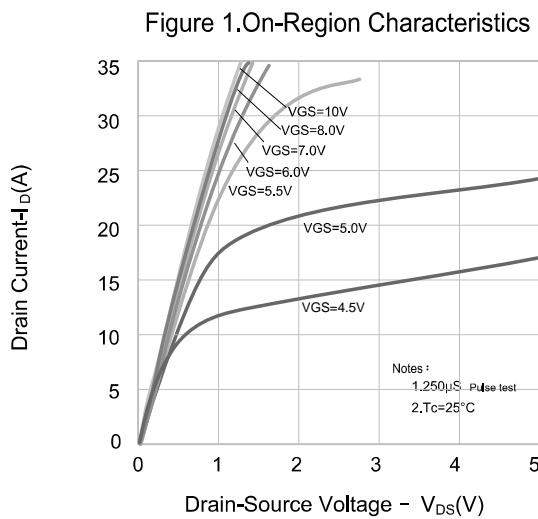
P-CHANNEL SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I _S	Integral Reverse P-N Junction Diode in the MOSFET	-	-	-7	A
Pulsed Source Current	I _{SM}		-	-	-28	
Diode Forward Voltage	V _{SD}	I _S =5A, V _{GS} =0V	-	-0.87	-1.3	V

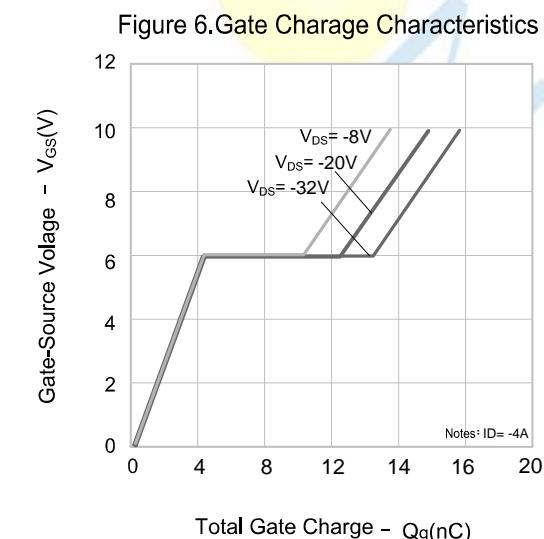
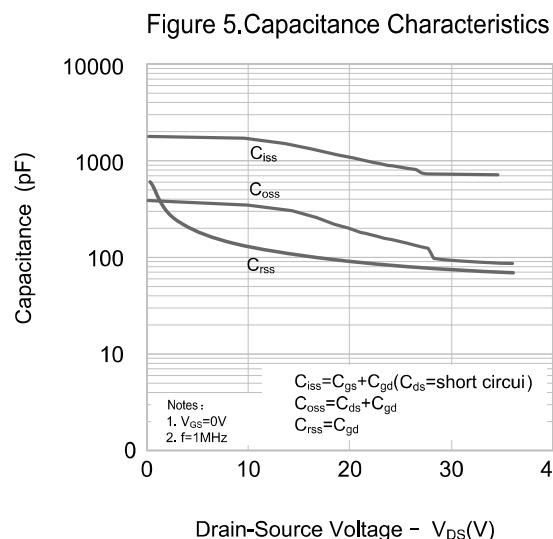
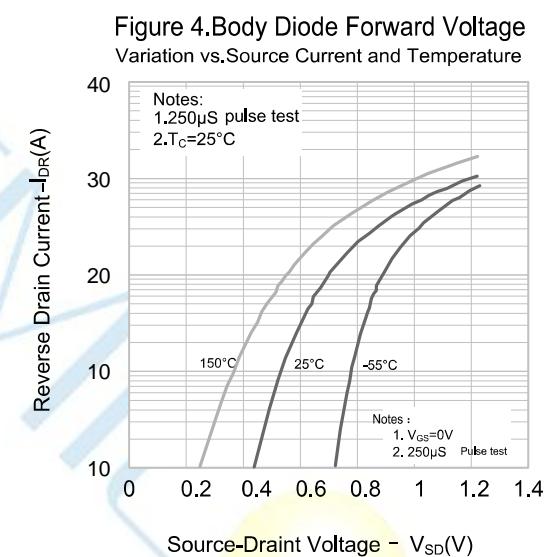
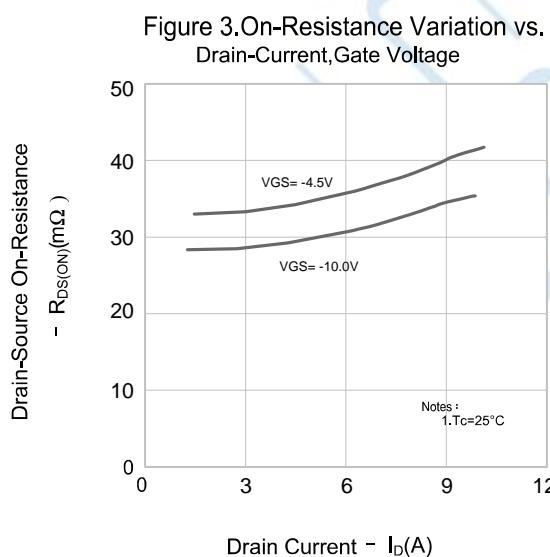
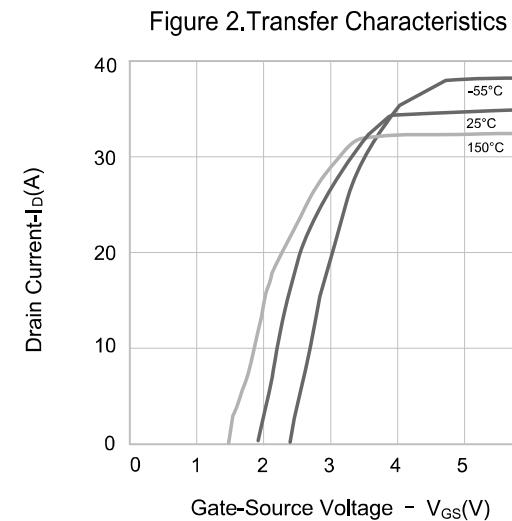
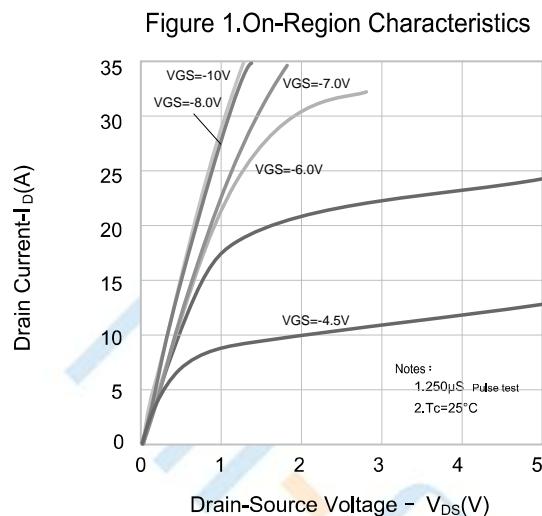
1. Pluse width limited by maximum junction temperature

2.Pulse Test: Pulse width ≤300μs, Duty cycle≤2%

3.Essentially independent of operating temperature

N-CHANNEL Typical Performance Characteristics

P-CHANNEL Typical Performance Characteristics



Typical Performance Characteristics

Figure 7.Breakdown Voltage Variation vs.Temperature

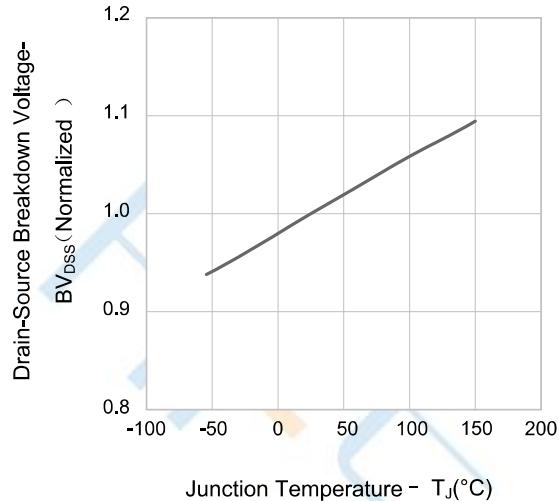


Figure 8.On-resistance Variation vs.Temperature

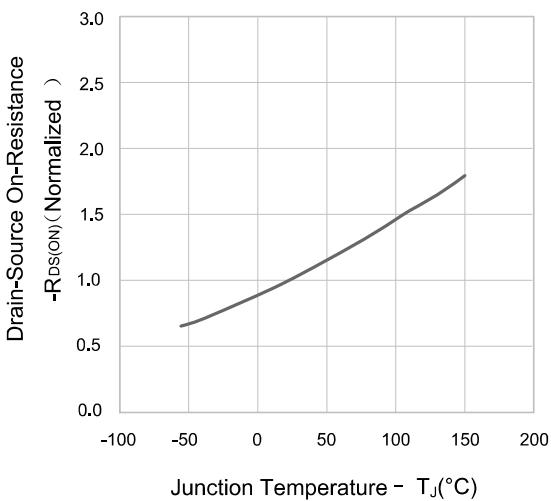
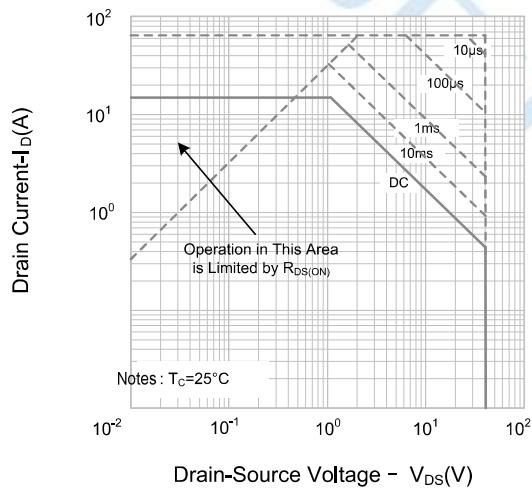
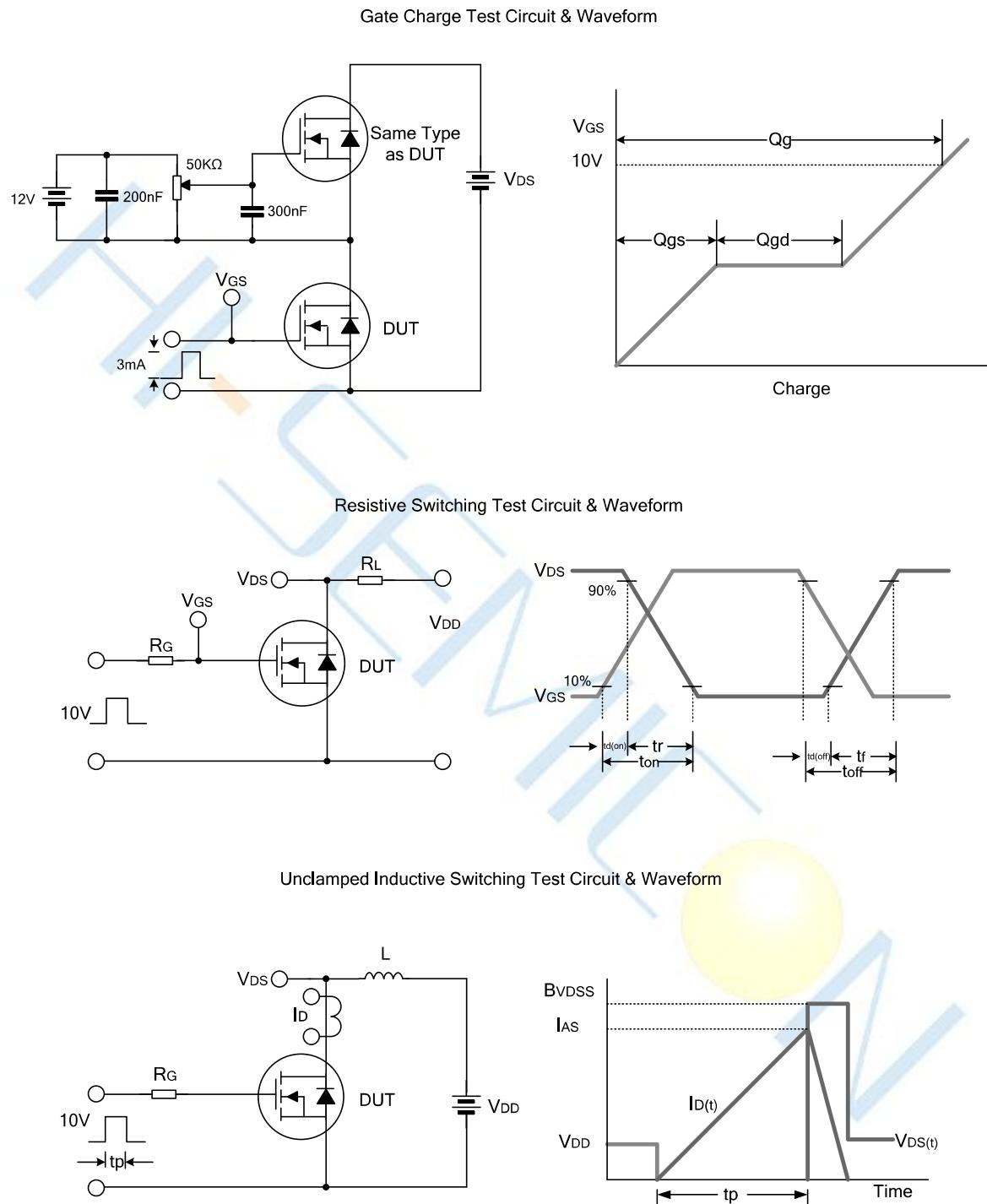


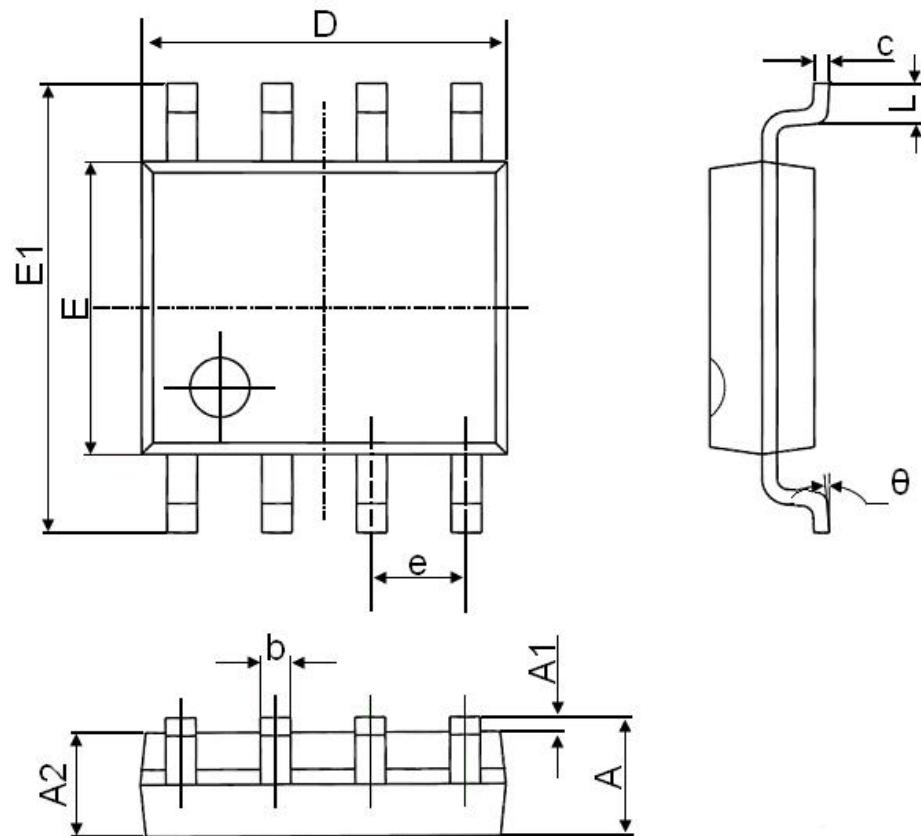
Figure 9.Max.Safe Operating Area



Test Circuit



Package Dimensions of SOP8-8L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270 (BSC)		0.050 (BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

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